FORM PTO 1449 (mod	•		ATTY DOCKET NO. 03500.015727.1	APPLICATION NO.	NYA		
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		U.S. F	PATENT DOCUMENTS				
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	6,624,589	9/03	Kitamura et al.	315	169.3		
	6,628,053	9/03	Den et al.	313	310		
	6,626,719	9/03	Ono et al.	445	24		
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	WO 01/93292	12/01	PCT				
	10-149760	6/98	JAPAN			ABSTRACT	
	OTHER I	DOCUMENT(S) (Inc.	luding Author, Title, Date, Pertiner	nt Pages, Etc.)			

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			U.S. PATENT DOCUMENTS			2017		
*EXAMINER	DOCUMENT		U.S. PATENT DOGGMENT			FILING DATE		
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		AP	APPLICANT TAKEO TSUKAMOTO				
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			neering of Carbon Nanostructures	s," Langm	uir 11,	
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Sheet 9 of 12

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FORM PTO 1449 (modified)

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LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)

ATTY DOCKET NO.

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APPLICATION NO.

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TAKEO TSUKAMOTO

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APPLICATION NO.

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